

<b>Notice of References Cited</b>	Application/Control No. 10/568,099	Applicant(s)/Patent Under Reexamination HIGASHI ET AL.	
	Examiner Bryan P. Bui	Art Unit 2153	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0005135	01-2003	Inoue et al.	709/229
*	B	US-6,942,143	09-2005	Iida et al.	235/379
*	C	US-6,141,754	10-2000	Choy, David M.	726/1
*	D	US-6,425,011	07-2002	Otani et al.	709/225
*	E	US-7,010,809	03-2006	Hori et al.	726/26
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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